

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10824874	BALLEW ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Geib, Benjamin	2181	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
712	10	8/28/2009	BPG
710	316	8/28/2009	BPG

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST search	8/28/2009	BPG
NPL search (IEEE Xplore and Google Scholar)	8/28/2009	BPG
Inventor name search	8/28/2009	BPG

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
712	10	8/28/2009	BPG

--	--